

P-Channel 30 V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}$ (m Ω)(Typ.)	I _D (A)	Q _g (Typ.)		
- 30	21 at V _{GS} = - 10 V	- 35 ^a	22 nC		
- 30	30 at V _{GS} = - 4.5 V	- 25 ^a	22110		

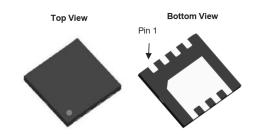
FEATURES

- DT-Trench Power MOSFET
- Thermally Enhanced DFN3X3 Package
 - Small Footprint Area
 - Low On-Resistance

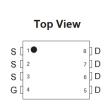


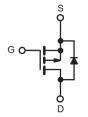
APPLICATIONS

 Load Switch, PA Switch, and Battery Switch for Portable Devices



DFN3x3-8L





P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (T _A = 25 °C, unless otherwise noted)					
Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V_{DS}	- 30	V	
Gate-Source Voltage		V_{GS}	± 20	v	
	T _C = 25 °C		- 35 ^a		
Continuous Drain Current (T _{.I} = 150 °C)	T _C = 70 °C	I _D	- 25 ^a		
Continuous Brain Current (1) = 100 °C)	T _A = 25 °C	טי	- 16 ^{b, c}		
	T _A = 70 °C		- 9 ^{b, c}	Α	
Pulsed Drain Current (t = 300 μs)		I _{DM}	- 140		
Continuous Source-Drain Diode Current		I _S	- 35 ^a		
Continuous Source-Drain Blode Current	$T_A = 25 ^{\circ}C$	is is	- 12 ^{b, c}		
	$T_C = 25 ^{\circ}C$	P _D	38	W	
Maximum Power Dissipation	$T_C = 70 ^{\circ}C$		25		
	T _A = 25 °C		3.5 ^{b, c}		
	$T_A = 70 ^{\circ}C$		2.1 ^{b, c}		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150	°C	
Soldering Recommendations (Peak Temperature) ^{d, e}			260	O	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, f}	t ≤ 5 s	R _{thJA}	27	35	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	R _{thJC}	3.3	4.5	C/ VV	

Notes:

- a. Package limited.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 2 s.
- d. See solder profile The DFN3X3 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under steady state conditions is 80 °C/W.





Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static						
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = - 250 μA	- 30			V
V _{DS} Temperature Coefficient	ΔV _{DS} /T _J	I _D = - 250 μA		- 11		mV/°C
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	Ι _D = - 230 μΑ		2.7		
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 1		- 3	V
Gate-Source Leakage	I _{GSS}	V _{DS} = 0 V, V _{GS} = ± 8 V			± 100	nA
Zoro Cata Voltago Prain Current	1	V _{DS} = - 30 V, V _{GS} = 0 V V _{DS} = - 24 V, V _{GS} = 0 V, T _J = 55 °C			- 1	μA
Zero Gate Voltage Drain Current	I _{DSS}				- 10	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le -5 \text{ V}, V_{GS} = -4.5 \text{ V}$	- 35			Α
	R _{nor} ,	V _{GS} = - 10 V, I _D = - 10 A		21	25	1
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = - 4.5 V, I _D = - 5 A	30 35		35	mΩ
Forward Transconductance ^a	g _{fs}	V _{DS} = - 10 V, I _D = - 10 A		40		S
Dynamic ^b				1		1
Input Capacitance	C _{iss}			1440		
Output Capacitance	C _{oss}	V _{DS} = - 15 V, V _{GS} = 0 V, f = 1 MHz		165		pF
Reverse Transfer Capacitance	C _{rss}			155		
Total Gate Charge	Qg			22		
Gate-Source Charge	Q _{gs}	V _{DS} = - 15 V, V _{GS} = - 10 V, I _D = - 10 A		13		nC
Gate-Drain Charge	Q _{gd}			3.3		
Gate Resistance	R _g	f = 1 MHz		13		Ω
Turn-On Delay Time	t _{d(on)}			16		
Rise Time	t _r	$V_{DD} = -15 \text{ V}, R_{L} = 0.75 \Omega$		17		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong -5 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_g = 1 \Omega$		21		
Fall Time	t _f			44		
Turn-On Delay Time	t _{d(on)}			11		ns
Rise Time	t _r	$V_{DD} = -15 \text{ V}, R_{L} = 0.75 \Omega$		15		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong$ - 10 A, V_{GEN} = -10 V, R_g = 1 Ω		30		
Fall Time	t _f			43		
Drain-Source Body Diode Characterist	ics					
Continuous Source-Drain Diode Current	Is	T _C = 25 °C			- 35	
Pulse Diode Forward Current	I _{SM}				140	A
Body Diode Voltage	V _{SD}	I _S = - 10 A, V _{GS} = 0 V		- 0.7	- 1.2	V
Body Diode Reverse Recovery Time	t _{rr}			40		ns
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = - 10 A, di/dt = 100 A/μs, T _J = 25 °C		20		nC
Reverse Recovery Fall Time	t _a	$_{\text{IF}}$ = - 10 A, di/dt = 100 A/ μ s, 1 $_{\text{J}}$ = 25 C.		15		
Reverse Recovery Rise Time	t _b			26		ns

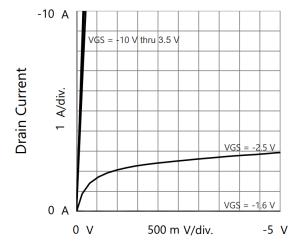
Notes:

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

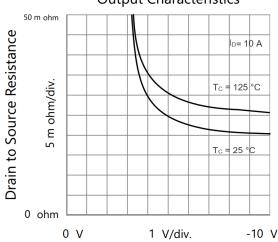
a. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 %. b. Guaranteed by design, not subject to production testing.



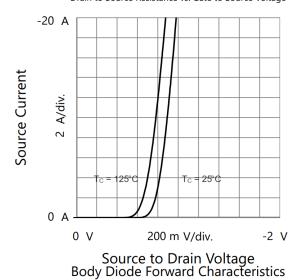
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Drain to Source Voltage Output Characteristics

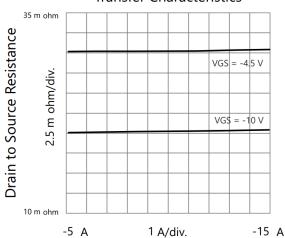


Gate to Source Voltage
Drain to Source Resistance vs. Gate to Source Voltage

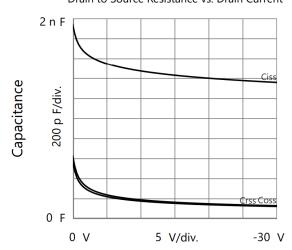


Or 300 m V/div. -3 V

Gate to Source Voltage Transfer Characteristics



Drain Current
Drain to Source Resistance vs. Drain Current



Drain to Source Voltage Capacitances



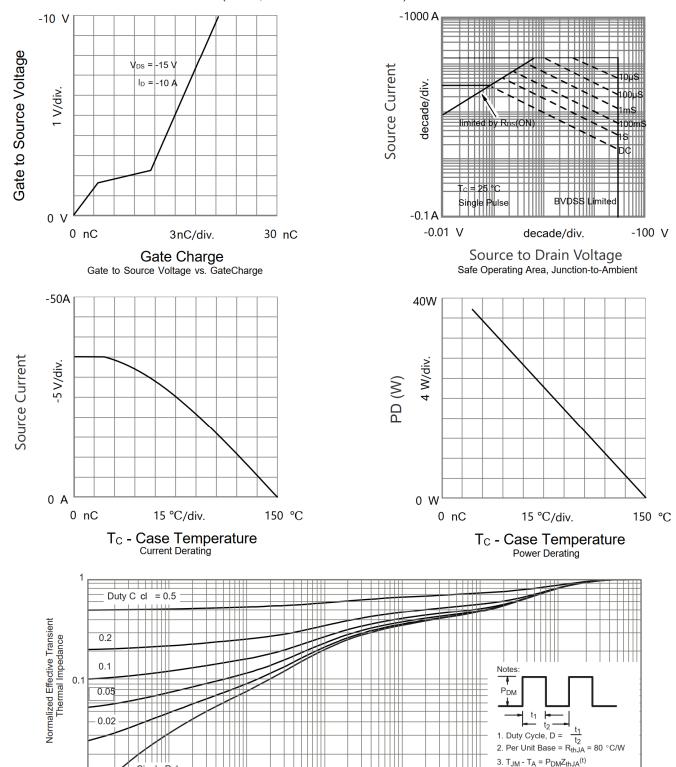
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

Single Pulse

10-3

10-2

0.01 L 10⁻⁴



Square Wave Pulse Duration (s)

Normalized Thermal Transient Impedance, Junction-to-Ambient

10-1

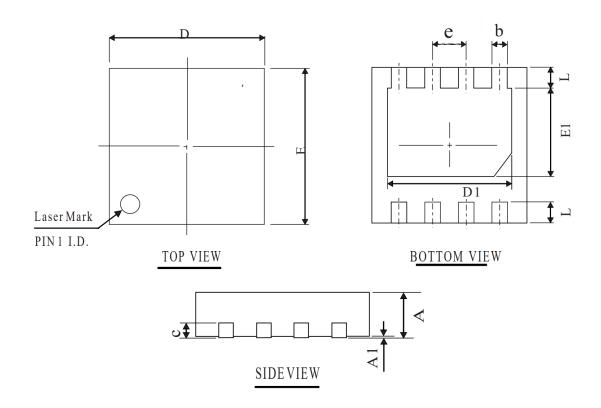
1000

4. Surface Mounted

100



DFN3*3-8L PACKAGE OUTLINE



COMMONDIMENSIONS (UNITS OF MEASURE=mm)

SYMBOL	MIN	NOM	MAX
A	0. 60	0.75	0. 90
A1	0. 00	0.02	0. 08
ь	0. 20	0.30	0.45
D	2.85	3.00	3. 15
Е	2. 85	3.00	3. 15
D1	2. 10	2.40	2. 70
E1	1.50	1.70	2.00
L	0. 20	0.40	0.60
С	0. 203 REF		
e	0. 65 BSC		

OTHER DIMENSIONS

A	0. 50	0.55	0.60
A	0.40	0.45	0.50







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